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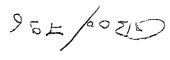
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2046K66 E442920-9 D01226

Surface Technology Systems Limited,

F01/7700 0.00 - 9909856.8

The Patent Office

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Request for grant of a patent

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each applicant (underline all surnames) Full name, address and postcode of the or of .ć

.tue Iqu Newport, Imperial Park,

United Kingdom 10097395270

country/state of its incorporation If the applicant is a corporate body, give the

"Chlorotrifluorine Gas Generator System

Wynne-Jones, Laine & James

ergo ini. Gloucestershire, суеттепраму 22 Rodney Road,

1792001

Patents ADP number (if you know it)

Name of your agent (if you have one)

Patents ADP number (if you know it)

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5. Patent application number

1. Your reference

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give the number and the filing date of derived from an earlier UK application, 7. If this application is divided or otherwise

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to grant of a patent required in support of Is a statement of inventorship and of right

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Title of the invention

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"Chlorotrifluorine Gas Generator System"

toxic, but require plasma or other excitation means to allow nsed in preference to gases such as NF, which are also highly after other plasma processes. This is more effective and clean" gas to remove very effectively deposits and build-up has recently become increasingly utilised as a "dry chambercandidate to achieve an improved etch process capability and Chlorotrifluorine (ClF $_3$) is known to be a likely

a significant impact on the overall performance of the particular attention. These design considerations can have ity of installation materials and thermal gradients require International, July 1997, p253). Issues such as compatibilhave been discussed in detail by Verma et al (Semiconductor Cylinder ClF3 gas delivery systems are most commonly used and precursor gas or by local electrolytic cell generation. supply, either using a conventional cylinder containing the The prior art comprises two alternative methods of ClF,

is solid at ambient temperatures. A limitation of either special storage requirements on-site, as the dry cartridge ders of extremely hazardous ClF, to be transported nor any the advantages that there are neither liquid filled cylinallows the delivery of ClF; (in a nitrogen carrier gas), with availability of "dry" cartridge delivery systems. This torm and, very recently, developments have focused on the Supply of ClF, has been available in liquid cylinder

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process.

etching at acceptable rates.

generation overcome some of these limitations. Such systems Newer delivery systems based on electrolytic cell enced by the gas delivery system during this process. variable pressure, temperature and flow parameters experi-This is because of the to liquefy in the gas lines. changes in the flow demands of the process may cause the gas it may be switched with another process gas, then the tion. For example if the gas is used in applications where situation may be further aggravated depending upon applicagas condensation in the delivery lines and components. The facilitisation and safety requirements in order to prevent additional səsod SIUL ·pəsn commonly sţ]scket for processing, a single cylinder using an external-heating To achieve the high gas flow rates and pressures required from a conventional cylinder as a low vapour-pressure gas. \mathtt{ClF}_3 (which is a liquid at ambient temperature) is delivered conditions, which could affect the process reproducibility. that they are both subject to fluctuations in the ambient the liquid cylinder or dry cartridge ClF, delivery syste

Newer delivery systems based on electrolytic cell generation overcome some of these limitations. Such systems are only just becoming commercially available. However a dedicated ClF, delivery installation is still needed. Limitations of this dry cartridge ClF, delivery system include gas flow fluctuations caused by changes in the reproducibility. The cost of the process gas is similar to reproducibility. The cost of the process that for supply of ClF, in liquid form but the dry cartridges require exchanging and this will require a service infrastructure and support to be established. In addition, this structure and support to be established. In addition, this

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method only allows ClF_3 to be generated in the presence of an

 N^{5} carrier gas.

ClF, suffers from a combination of increased cost over existing chemistries, greater health and safety risks and limited commercial availability. These factors combine to make the economics and practicalities of implementing this chemistry potentially difficult and/or the installation and transportation thereof extremely hazardous.

According to the invention there is provided a ClF₃ gas generation system wherein supply sources of chlorine and fluorine are connected into a gas reaction chamber enabling generation of ClF₃ gas, and the reaction chamber has a valved

fluorine are connected into a gas reaction chamber has a valved generation of ClF, gas, and the reaction chamber has a valved outlet for the supply of the ClF, gas.

The invention further extends to such a gas generator system wherein the valved outlet from the reaction chamber is connected to a single or multiple process chamber or

This invention provides for the generation of ClF, process gas on demand. The ClF, is generated locally to the process tool through the direct combination of the precursor gases, fluorine and chlorine, under controlled temperature and pressure reaction conditions. The use of the individual precursor gases offers a considerable improvement over many of the economic, and handling constraints of current methods of supplying ClF,. In particular, the recent commercial availability of an appropriately scaled local high-purity fluorine generator overcomes many of the safety issues of thandling pure high-purity fluorine required for the reac-

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tion.

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Direct reaction of Cl_2 and F_2 allows the local generation of the ClF_3 although the specific reaction products resulting from the reaction may include other reaction by-product species in the form of $\operatorname{Cl}_x\operatorname{F}_y$, but the dominant species can be maintained as ClF_3 . Apart from the reaction by-product species, the generated gas can be formed to the same high purity levels as the precursor gases. This high purity is easier to maintain in a smaller scale reaction chamber compared to much larger commercial volume generation systems. For the majority of applications envisaged, the systems. For the majority of applications envisaged, the other $\operatorname{Cl}_x\operatorname{F}_y$ is capaised and a systems. For the majority of applications envisaged, the systems. For the majority of applications envisaged, the

chamber compared to much larger commercial volume generation systems. For the majority of applications envisaged, the issues over ${\rm Cl}_{\rm x}{\rm F}_{\rm y}$ species are not expected to represent any process include lower production cost and ownership costs as well as include lower production cost and ownership costs as well as

The reaction chamber can be formed from high purity materials (such as those sold under the Trade Marks Monel (nickel/copper/iron alloy), Inconel (nickel/chromium/manganese sloy) and Hastalloy (nickel/molybdenum/chromium/manganese viron alloy)) which would not be financially feasible with

The gas generator for the invention operates with known precursor gases at or near atmospheric pressure, thus virtually eliminating the need for specialised gas delivery systems. Ideally though the gas generation system will be provided with a control system to control the rate of supply of gases from the two supply sources and through the valved

outlet from the reaction chamber.

large scale generation systems.

associated safety requirements such as gas monitoring reduced amount of pipe work for the additional gases and the significant reduction in the installation cost due to the There would be a cylinders for the actual gas supply. compared with the cost requirement using high-pressure gas from the ClF, gas generator is very competitive as The generation of the process any maintenance operations. frons needed to protect the operator during use and during also eliminated, which reduces the level of safety precaucontaining hazardous chemicals, to the process equipment are Specialised gas delivery systems, associated risks. to the processing environment are eliminated along with the fluorine on demand from a central store on the installation corrosion etc. Long gas lines for the local generation of This reduces hazardous chemical storage problems and risk of demands gas generation (of fluorine gas, followed by ClF₃). hazardous gases in the installation, until the process Other than this, there are no extremely techniques. plants in the utilisation of semiconductor manufacturing Cl2, which is already commonly used in most fabrication The most hazardous gas used in the installation will be

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The reaction chamber may be operated at or near atmospheric pressure, going up the range from several Torr to 760 Torr. The reaction chamber temperature up to 600°C controlled at between ambient room temperature up to 600°C generally, but probably will lie within the range of 100 - 400°C. Differing temperatures may be maintained in at least 2 separate zones of the reaction chamber.

reaction chamber.

The salety requirements for the precursor gases are

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systems.

fluorine and chlorine.

The introduction of high purity gases removes the need to "polish" the generated ClF_3 to remove unwanted impurities before passing into the process chamber. The generation of fluorine locally to the tool overcomes the commercial difficulties in obtaining high purity 100% fluorine in a high pressure cylinder and in the quantities required. The choice of supply of chlorine is from high-pressure cylinchoice of supply of chlorine is from high-pressure cylinders, which are commercially readily available and commonly installed within the industry. Other appropriate methods of chlorine simply may be used. Mass flow controllers may be used to precisely meter the flow of Cl_2 and F_2 into the used to precisely meter the flow of Cl_2 and F_2 into the

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reaction chamber and the delivery pressure of the supplied chamber is then independent of the higher pressure in the The process process chamber via a pressure control system. schieved by allowing the gas product to flow into the This can be independent of the process chamber pressure. bressures reaction chamber design allows operation at LPG CIE3 gases that may prejudice the overall process. adverse reactions during the combination of the precursor design of the system will be such as to avoid possible controlled reaction chamber that is local to the tool. precursor gases through a simple heated and pressure-ClF, for the process chamber by passing the relatively safe The direct combination of precursor gases can provide

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the absence of any ClF, when the system is not being used for The maintenance of the complete system is eased by pe raken for the supply of such gas from a centralised eliminates additional safety precautions that would need to chlorotrifluorine within a sub-component of a process tool The production of the case for chlorotrifluorine. already commonplace for the targeted industry. This is not

reaction chamber. The flow rates that can be achieved are ensures that the ClF, is only produced as required from the The design of a custom-built iluorine-on-demand generator consumption is optimised and excess generated gas avoided. that required for the specific application so that the gas -The quantity of the generated gases can be regulated to

proscribed for ClF, delivery from a central store. not subject to gas delivery restrictions which might be SI

which is a diagrammatic illustration of a typical system of of example, with reference to the accompanying drawing, preferred embodiment thereof will now be described, by way The invention may be performed in various ways and a

a cylinder 3 of compressed chlorine. The fluorine source is and pressure controlled conditions. The chlorine source is chlorine and fluorine are combined under conventional heat from a local reaction chamber 2 where precursor gases utilising that gas is to take place. The ClF; is delivered cylorotrifluorine to a process chamber 1 where a dry process The system shown in the drawing is for supplying

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the invention.

brocessing.

a conventional fluorine generator 4. Appropriate valving will include valves provided at A, B, C and D for appropriate ate isolation and control means. Linked control systems 5 and 6 monitor and maintain the supply to and conditions in

From the process chamber gases pass to an exhaust system 7, which in turn leads to an abatement tool 8 (which is usually needed). A bypass outlet 9 leads from the reaction chamber 2 to the exhaust system, whereby gases can be switched into the process chamber 1 only when required for processing. This also allows means for ensuring stable for processing. This also allows means for ensuring stable

gas composition and flow to be maintained prior to switching into the process chamber.

the chambers 1 and 2.

CLAIMS

- cylorine supply source comprises a cylinder of compressed A system according to claim 1, wherein the chamber has a valved outlet for the supply of the ClP, gas. chamber enabling generation of ClF, gas, and the reaction of chlorine and fluorine are connected into a gas reaction A ClF, gas generation system wherein supply sources
- A system according to claim 1 or claim 2, wherein cyjozine.
- wherein a control system is provided to control the rate of A system according to any one of claims 1 to 3, the fluorine supply source is a fluorine generator.
- valved outlet from the reaction chamber. anbbjh of dases from the two supply sources and through the
- connected to a process chamber or processing tool in which wherein the valved outlet from the reaction chamber is A system according to any one of claims 1 to 4, SI
- ment tool is connected from the output of the processing 20 A system according to claim 5, wherein an abate-

the ClF, gas will be utilised.

composition and/or flow prior to supply of the generated ClF, abatement tool to enable the process to build up to a stable connection is provided from the reaction chamber to the 7. A system according to claim 6, wherein a bypass chamber or tool.

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A system according to claim 6, wherein a bypass to the process chamber or tool.

the process chamber as and when required to allow a continuabatement tool to enable the flow of ClF3 to be switched into connection is provided from the reaction chamber to the

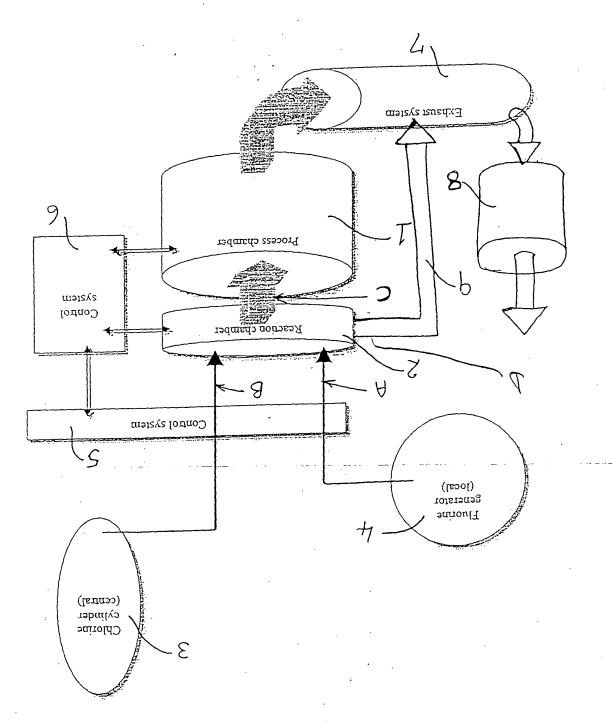
reaction product is fed on to a local processing chamber or chamber, a combination reaction is performed and the ClF₃ gases are fed from the supply sources to the reaction claimed in any one of claims 1 to 8, wherein the precursor 9. A method of generating ClF, gas using a system as

ClF, gas and substantially as herein described with reference 10. A gas generation system or method for generating

to the accompanying drawings.

ous generation of ClF3.

tool.



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